Application/Control No. Applicant(s)/Patent Under Reexamination 10/710,317 **BONALLE ET AL.** Notice of References Cited Examiner Art Unit Page 1 of 1 Daniel I. Walsh 2876 **U.S. PATENT DOCUMENTS** Document Number Date Classification Country Code-Number-Kind Code Name MM-YYYY US-2005/0232471 10-2005 Α Baer, Richard 382/115 * US-5,988,497 Wallace, Michelle H. В 11-1999 235/382.5 US-С US-D US-Ε US-F US-G US-Н USı J US-US-Κ US-L US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY N 0 Р Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W Х

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